Achieving Small Dimensions with an Environmentally Friendly Solvent: Photoresist Development Using Supercritical CO₂

Nelson Felix¹, Anuja De Silva², and Christopher K. Ober³

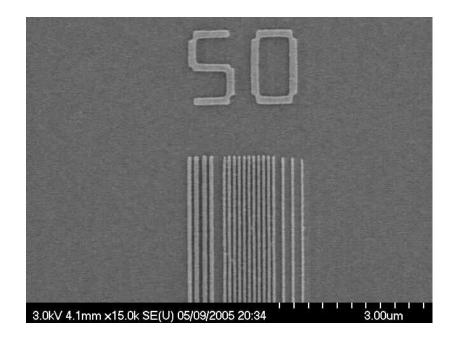
¹School of Chemical and Biomolecular Engineering, Cornell University ²Department of Chemistry and Chemical Biology, Cornell University ³Department of Materials Science and Engineering, Cornell University

ERC Teleseminar, Nov. 1, 2007



Outline

- Supercritical CO₂ as a development solvent
 - Advantages
 - Use with polymeric photoresist systems
- Small molecule photoresists
 - Potential advantages
 - Solubility in scCO₂
 - Patterning performance

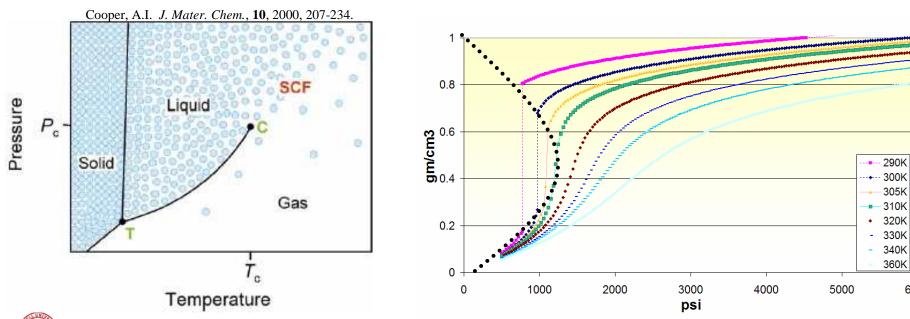


Supercritical CO₂ Basics

Supercritical CO₂

 Tunable, non-polar solvent with the ability to dissolve select non-polar materials

 $-T_c = 31C, P_c = 1070psi (77 bar)$



6000

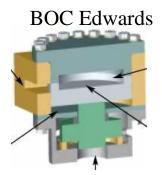
Supercritical CO₂ in Industry

- Extraction of essential oils from organic matter
 - Cinnamon, ginger, sandalwood, etc
 - Pharmaceutical applications



- Decaffeination of coffee
 - CO₂ replaced CH₂Cl₂ as solvent, removed only caffeine

- Dry Cleaning
 - Addition of surfactants
- Wafer cleaning
 - BOC Edwards DFP-200
 - Critical Point Dryer



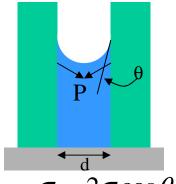


Next Generation Lithography: Key Problems

Pattern Variations < 3nm for 32nm node

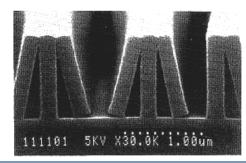
Pattern Collapse

Reduce surface tension

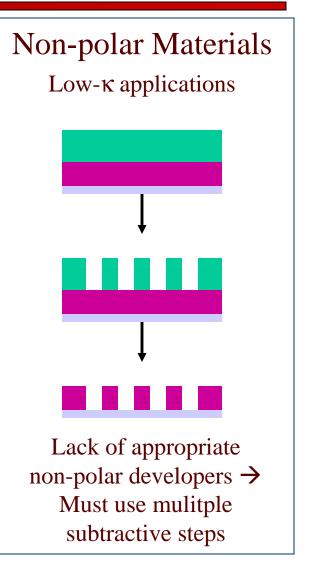


$$P = \frac{\sigma}{R} = \frac{2\sigma\cos\theta}{d}$$

@ 50nm L/S, aspect ratios >2:1 collapse w/water

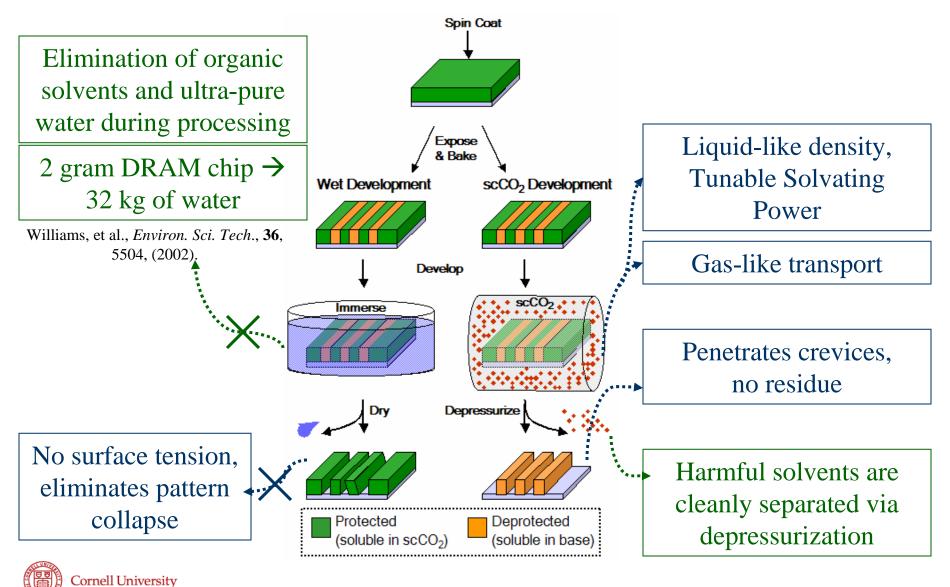


T. Tanaka, M. Morigami, N. Atoda, *JJAP*, **32**(pt1, 12B) 6059 (1993).



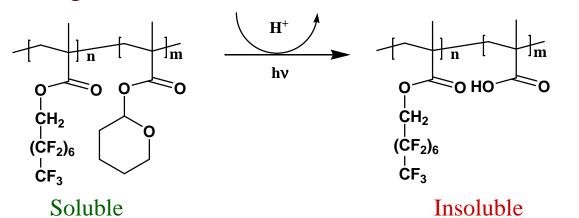


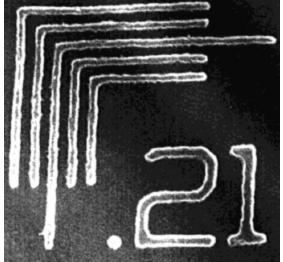
Advantages of Supercritical CO₂ Development



Fluorinated scCO2 Soluble Photoresists

- First platform for soluble polymeric photoresists
 - Copolymerize traditional photoresist monomers with fluorinated monomers
- Negative tone





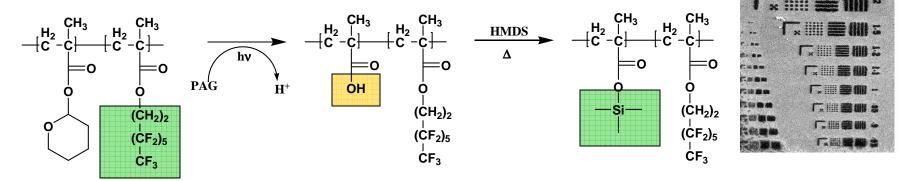
Sundararajan, et al. 193 nm exposure.

- Block copolymer (Cornell) and random copolymer (UNC) versions demonstrated.
- N. Sundararajan, S Yang, K Oglno, S Vallyaveettfl, J Wang, X Zhou, C. K. Ober, S. K. Obendorf, and R. D. Allen, *Chem. Mater.* 12, 41 (2000). D. Flowers, E N Hogan, R Carbonell, mad J. M. DeSlmone, in Proceedings of SPIE, 4690, 419 (2002).



Positive Tone Resists for scCO₂ Development

Two-step positive-tone



Pham, V Q., et al., *Chem. Mater.* 15(26), 2003, 4893-5.

• Balance must be struck between resist solubility (increase F) and contrast (increase functionality)

Resist Fluorination

Advantages

- High transparency at 193 nm, 157 nm exposure wavelengths
 - Library of fluorinated monomers
- Simple to increase scCO2 solubility with monomer inclusion

Disadvantages

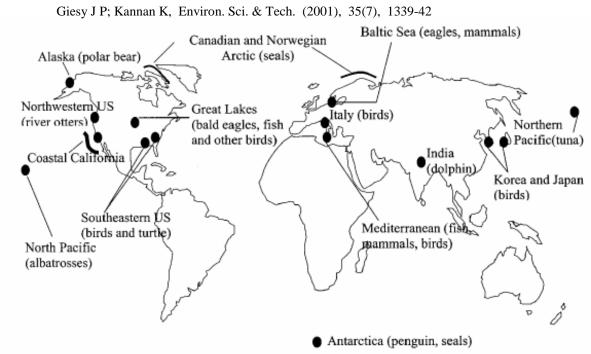
- Low plasma etch resistance of F-containing structures
- Surface compatibility: low surface energy
- Low glass transition temperatures (Tg)
 - Difficult to keep sharp pattern shape
 - Low contrast



Reduce Fluorination

Perfluorinated octyl compounds have been shown to bioaccumulate and disrupt cellular functions

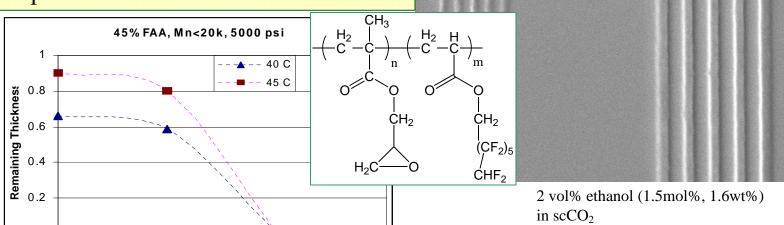
Environmentally friendly? → reduce need for fluorination



Reducing Fluorination: Using Cosolvents

0.3 μm L/S

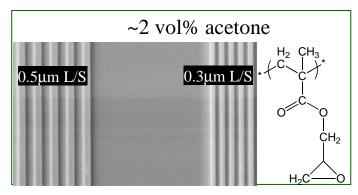
- Increase solvent density
- •Tune polarity of fluid
- Specific interaction with a comonomer



• 1vol% **ethanol**....very little effect

vol% ethanol in CO2

• 2vol% ethanol....100% removal



 $P = 5000 \text{ psi}, T = 45^{\circ}\text{C}, t = 10 \text{ min}$

0.5 μm L/S

Mao, Yu; Felix, N. et al., JVST B., 22(5), 2004, 2473-8.



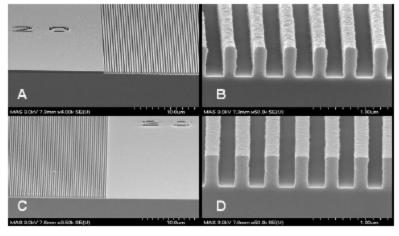
Additives for Processing Conventional Resists

- Patent literature full of examples of surfactant libraries used for scCO2 dissolution of photoresists
 - Fluorinated or hydrocarbon tails
 - Polar or carboxylate heads
 - Mostly seen for pattern cleaning/drying
- Recent work by Micell Technologies on reactive ionic additives to impart scCO2 solubility to conventional photoresists

'CO₂ Compatible Salts'

- Rather than ionic surfactants, reactive fluorinated salts added to solution
 - Interact with weak acidic groups of photoresist to impart solubility
 - Due to lower amounts of acidic groups, unexposed regions gain sufficient solubility first
 - Presence of generated acid in exposed regions inhibits reaction with photoresist

$$-N$$
 (CH₂)₃ -(CF₂)₅ -CF₃
(CH₂)₃
(CF₂)₅ Unknown
CF₃ counterion



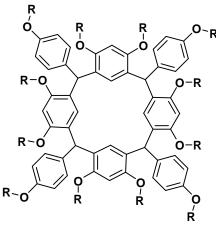
Aqueous TMAH develop

CO₂/CCS develop

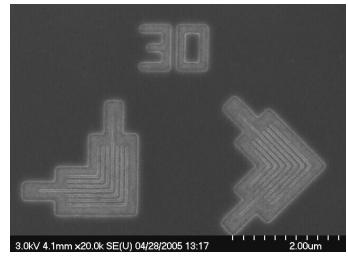
Wagner, M., DeYoung, J., and C. Harbinson, SPIE v 6153 I 2006, p 61531. DeYoung, J., et al., SPIE v 6153 I 2006, p 615345.

Molecular Glass Photoresists

- Small molecule size ~1-2nm
- Well defined molecular structures
 - No distribution of mass
- Low tendency towards crystallization
 - bulky irregular shape or different conformation states
- Strong intermolecular attractive forces for high Tg
 - Specific interactions such as Hbonding



R = -H or -tBOC

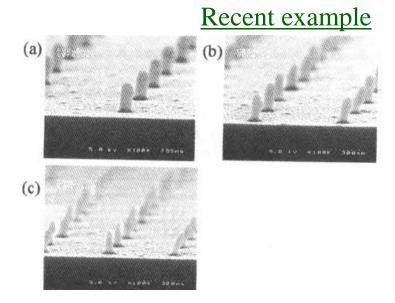


S. W. Chang, R. Ayothi, D. Bratton, D. Yang, N. Felix, H. B. Cao, H. Deng and C. K. Ober, *J. Mater. Chem.*, **16** (2006), 1470-74. Images obtained at Lawrence Berkeley National Laboratories by EUV microexposure tool

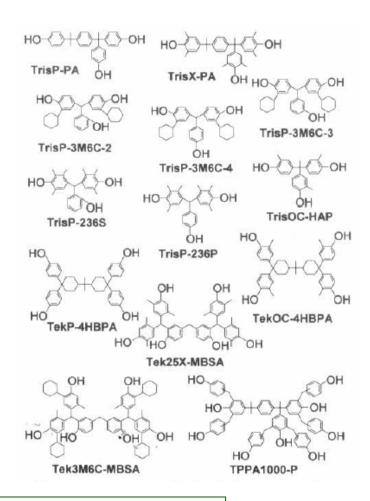


Molecular Glass Resist Solubility in scCO2

- Due to their small size, these resist materials have the potential for scCO2 solubility w/o fluorine
- Balance between size and polar functionality

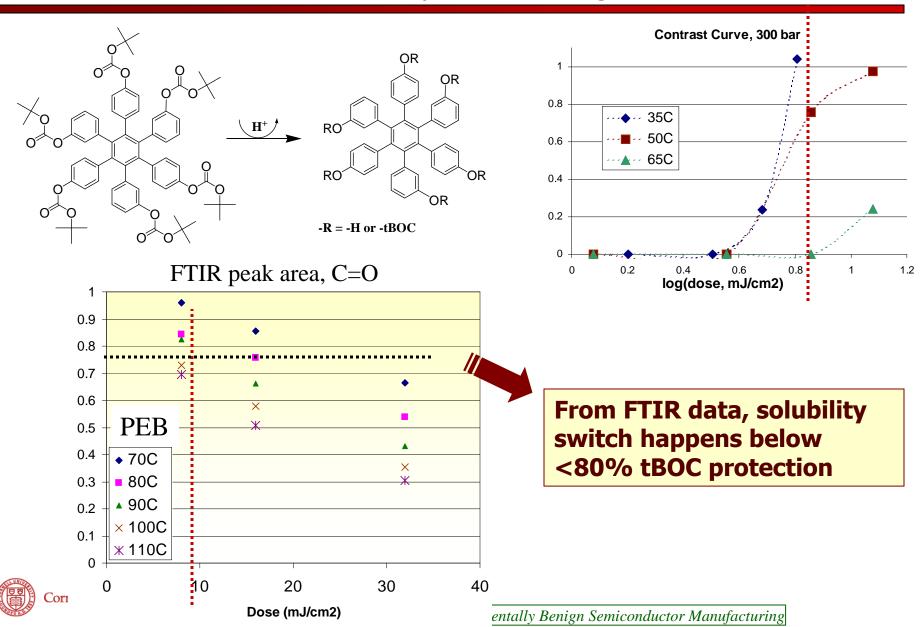


H. Shiraishi, J. Yamamoto, T. Sakamizu, *J. Photopolym. Sci. Technol.* **19**(3) (2006), 367-372.

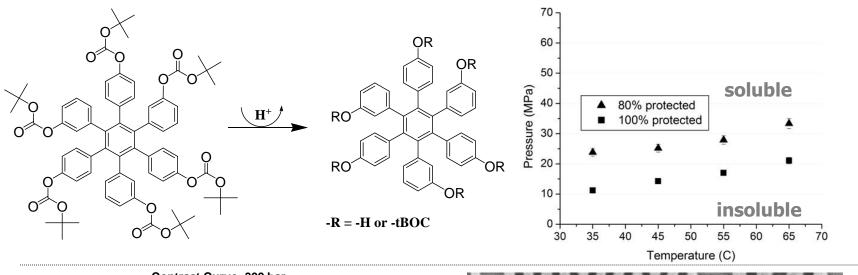


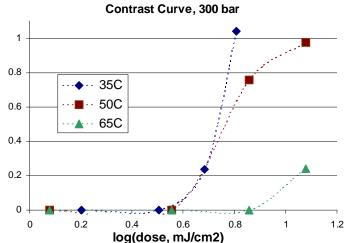


Solubility Switching

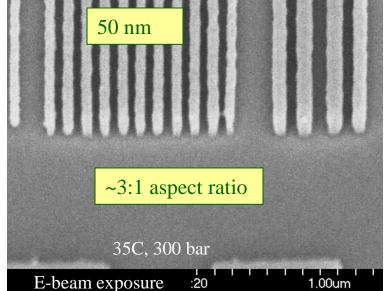


High Resolution MG Resist for Supercritical CO₂



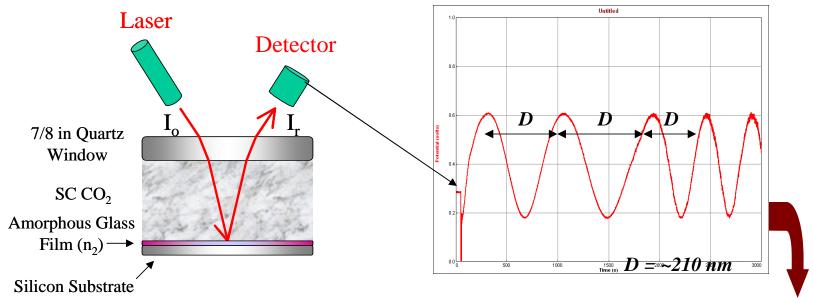


Felix, N. M, Tsuchiya, K., and C. K. Ober, Adv. Mater., 18(4), 2006, p 442-446.





Dissolution Rate Measurments





$$D = \frac{\lambda}{2\sqrt{n_2^2 - n_1^2 \sin^2(\theta)}}$$

 $\lambda = 632.8 \text{ nm}$

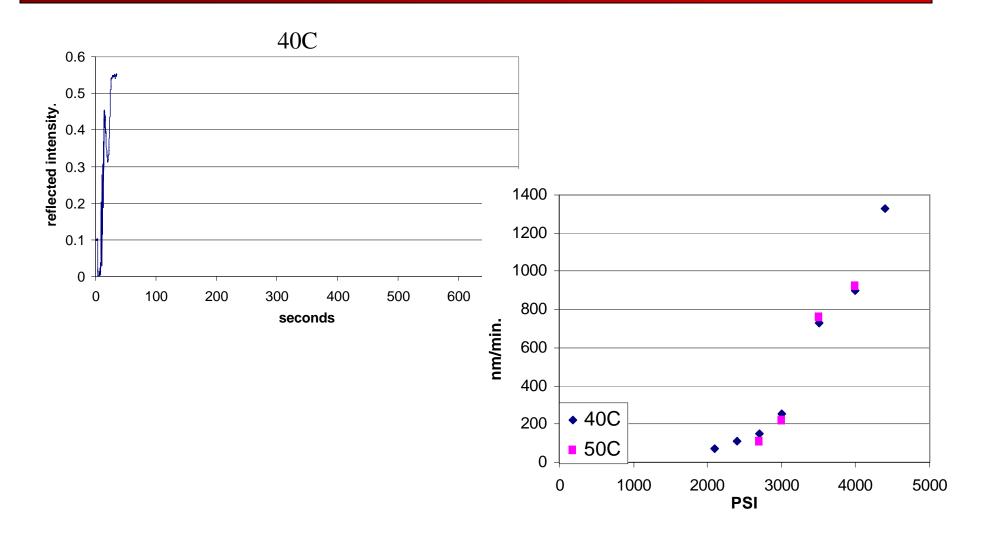
 n_1 = solvent refractive index

 n_2 = film refractive index (~1.55)

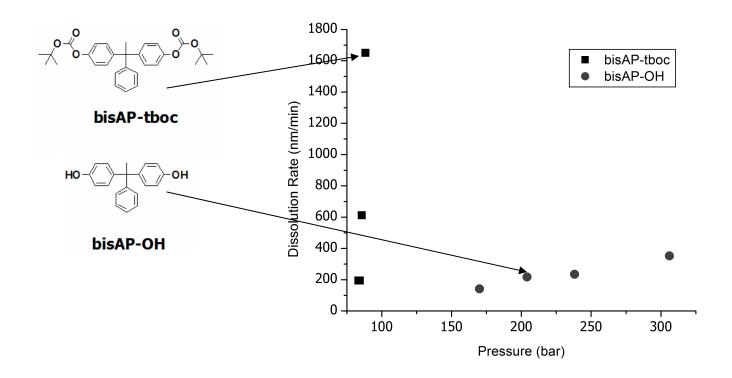


nmentally Benign Semiconductor Manufacturing

Increasing pressure



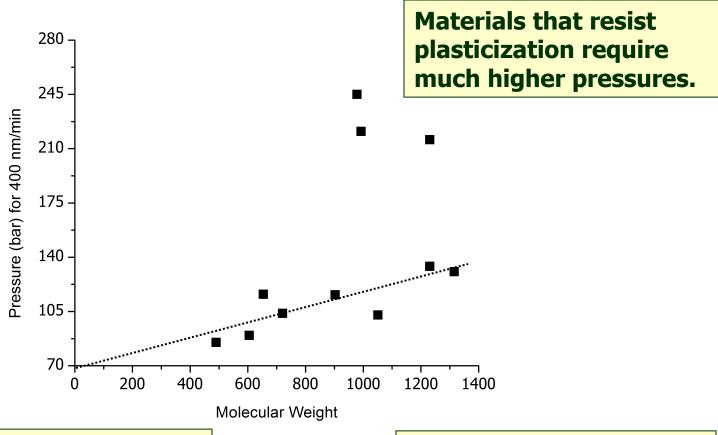
Effects of polarity



- Molecules with less than 3 –OH groups still significantly soluble.
- Effect more pronounced at lower temperatures.
- Indicative of contrast between exposed and unexposed regions.



Effect of molecular weight, Tg



Necessary pressure to achieve dissolution rate increases predictably with larger MW.

However, photoresists approaching 2000 g/mol still soluble in scCO2!



Going forward

- Methodology in place for predicting, measuring scCO₂ solubility, especially with small molecules
 - Patterning possible with high Tg materials
- Can be expanded to positive-tone materials
 - Need chain-scission type resist materials

Calix[4]resorcinarenes

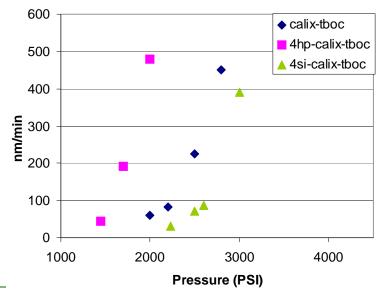
calix-tboc

4tb-calix-tboc

si-calix-tboc

Felix, N. M, et al., manuscript in preparation.

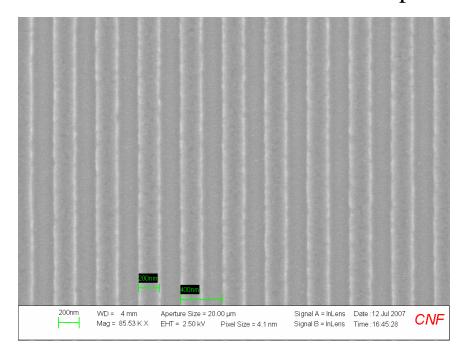
	Tg (C)
calix-tboc	107
4hp-calix-tboc	84
4tb-calix-tboc	110
4si-calix-tboc	140

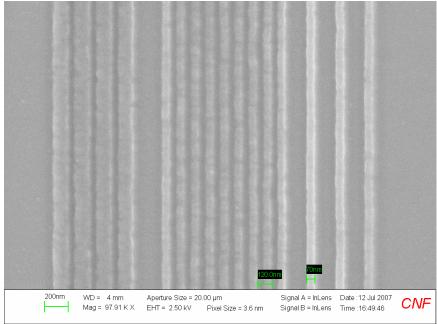




Patterning

Developed 37C, 2500psi (e-beam)

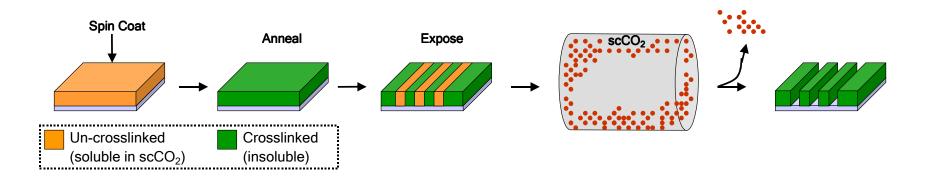




• As expected, sub-100nm performance shown with calix[4]resorcinarenes developed in scCO2

De-crosslinking Resists for Positive Tone

- PMMA is classic example
 - High resolution e-beam, EUV resist with low LER
 - Problem: low sensitivity
- Acid catalyzed de-crosslinking
 - Improved sensitivity
 - Use acetal bonds to crosslink otherwise scCO₂ soluble species



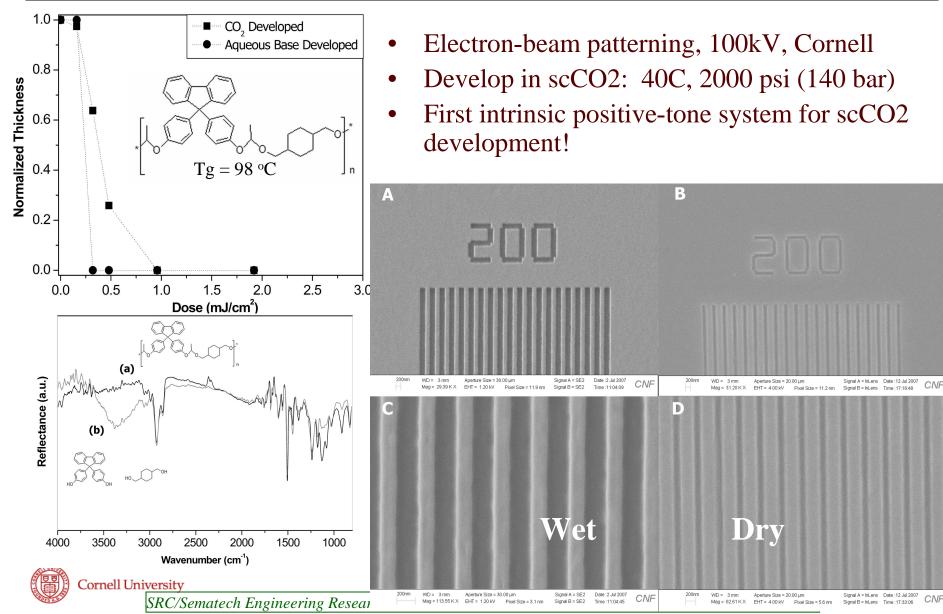


Acetal-backbone polymers

HO-OH + OO ON THE PPTS
$$r.t.$$
 HO-OH ho OH ho OH

- Optimal system for scCO2 development
 - Bisphenol-type compounds shown to be scCO2-soluble
 - Large changes in molecular weight lead to solubility contrast

Patterning



Summary

- Along with being environmentally friendly, supercritical CO2 shows performance advantages.
- Molecular glass photoresists have shown good performance, low LER under EUV patterning.
- Any given molecular glass platform has the potential for both base development and scCO2 development.
 - Molecules approaching 2000 g/mol significantly soluble
 - < 65nm features shown with select systems</p>
- First report of intrinsic positive-tone system for scCO2 development.

Acknowledgements

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